



Response under 37 C.F.R. 1.116
- Expedited Examining Procedure -
Examining Group 2623

MAIL STOP AF
81225PAL

Customer No. 01333

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Nathan D. Cahill, et al

LOCATION OF EXTENDED LINEAR
DEFECTS

Serial No. 09/635,178

Filed 09 August 2000

Commissioner for Patents
P.O. Box 1450
Alexandria, VA. 22313-1450

Sir:

Group Art Unit: 2623

Examiner: Virginia M. Kibler

I hereby certify that this correspondence is being
deposited today with the United States Postal
Service as first class mail in an envelope addressed
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Robin G. DePoint
Robin G. DePoint

August 16, 2004
Date

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AUG 25 2004

Technology Center 2600

DO NOT ENTER.
10/25/04 VMK

Response Under 37 CFR 1.116

In response to the Office Action dated May 14, 2004, please
amend the above-identified application as follow:

Amendments to the Claims are reflected in the listing of claims which begins on
page 2 of this paper.

Remarks/Arguments begin on page 5 of this paper.